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Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/523,697	LIN ET AL.	
Examiner	Art Unit	
Nghi H. Ly	2617	

	SEARCHED		
Class	Subclass	Date	Examiner
370	347 329	1/2/2008	NLY
455	450 522	1/2/2008	NLY
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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East search update.	1/2/2008	NLY
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